

**Search Notes**

Application/Control No.

09/698,159

Examiner

Ellen C. Tran

Applicant(s)/Patent under  
Reexamination

GHOSH ET AL.

Art Unit

2134

**SEARCHED**

Class	Subclass	Date	Examiner
726	23	10/3/2006	ECT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
INTERFERENCE SEARCH		10/3/2006	ECT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPG, USPTO, EPO, JPO, OCR, DERWENT, IBM TECH DES	10/3/2006	ECT
NPL - IEEE XPLORE	10/3/2006	ECT
INTERFERENCE SEARCH - USPG PUB	10/3/2006	ECT
All claims were reviewed for possible 101 rejection by Examiner	10/3/2006	ECT

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Class	Subclass	Date	Examiner
726	23	4/1/2006	ECT
706	15	4/1/2006	ECT
706	21	4/1/2006	ECT
706	23	4/1/2006	ECT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, IBM TECH DES, DERWENT	4/1/2006	ECT

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Class	Subclass	Date	Examiner
713	201	8/18/2005	ECT

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	8/18/2005	ECT



## SEARCH NOTES

(INCLUDING SEARCH STRATEGY)

	Date	Exmr.
INVENTOR	2 APR 64	ELT
DBL PAGE		
USPTO		
USPG		
EPO		
JPO		
DERWENT		
IBM TECH RS		
CONSULTED w/ SPE		
CONSULTED D 101 HELP PAGE		

Class	Sub.	Date	Exmr.

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